

INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)	Docket Number (Optional) 17449	Application Number Unassigned
	Applicant(s) Shuichi Ohkubo	
	Filing Date Herewith	Group Art Unit Unassigned

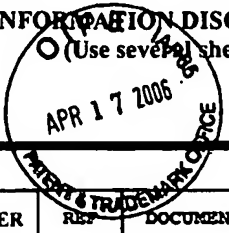
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS								
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
ALV		07-223372	8/22/95	Japan			X	
ALV		07-104424	4/21/95	Japan			X	
ALV		07-242970	9/8/00	Japan			X	
ALV		2002-293025	10/9/02	Japan			X	

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)		

EXAMINER <u>Ann Velice</u>	DATE CONSIDERED <u>11/15/00</u>
EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

INFORMATION DISCLOSURE CITATION
(Use several sheets if necessary)



Docket Number (Optional)
17449

Application Number
10/781,999

Applicant(s)

Shuichi Ohkubo

Filing Date

February 19, 2004

Group Art Unit

1752

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
ALV		2003-045085	2/14/03	Japan				
ALV		2002-144736	5/22/02	Japan				
ALV		2003-006860	1/10/03	Japan				
ALV		2002-211137	7/31/02	Japan				
ALV		2002-288876	10/4/02	Japan				
ALV		11-126366	5/11/99	Japan				
ALV		2002-237095	8/23/02	Japan				
ALV		2000-313170	11/14/00	Japan				
ALV		2002-230826	8/16/02	Japan				
ALV		2002-264515	9/18/02	Japan				
ALV		05-016528	1/26/93	Japan				
ALV		02-064929	3/5/90	Japan				

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

Ma Vudree

DATE CONSIDERED

11/15/06

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INFORMATION DISCLOSURE CITATION (Use several sheets if necessary)				Docket Number (Optional) 17449		Application Number 10/781,999		
				Applicant(s) Shuichi Ohkubo				
				Filing Date February 19, 2004		Group Art Unit 1752		
U.S. PATENT DOCUMENTS								
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE		
ALV	2001/0036528A1	11/1/01	Abiko et al.					
FOREIGN PATENT DOCUMENTS								
	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
ALV		01-180387	7/18/89	Japan				
ALV		CN 1320260A	10/31/01	China				
ALV		WO 01/13370 A1	2/22/01	PCT				
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)								
EXAMINER <i>Alan Vukobratovic</i>				DATE CONSIDERED <i>11/15/00</i>				
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				Applicant(s) Shuichi Ohkubo			
				Filing Date February 19, 2004		Group Art Unit 1752	

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	REF	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
ALV		5,789,055	8/4/1998	Yoon			
ALV		2002/0146643 A1	10/10/2002	Shingai			

FOREIGN PATENT DOCUMENTS

	REF	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
ALV		EP 1 172 811 A2	1/16/2002	EPO				
ALV		EP 1 229 530 A2	8/7/2002	EPO				

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER <i>Ana Verdine</i>	DATE CONSIDERED <i>11/15/06</i>
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